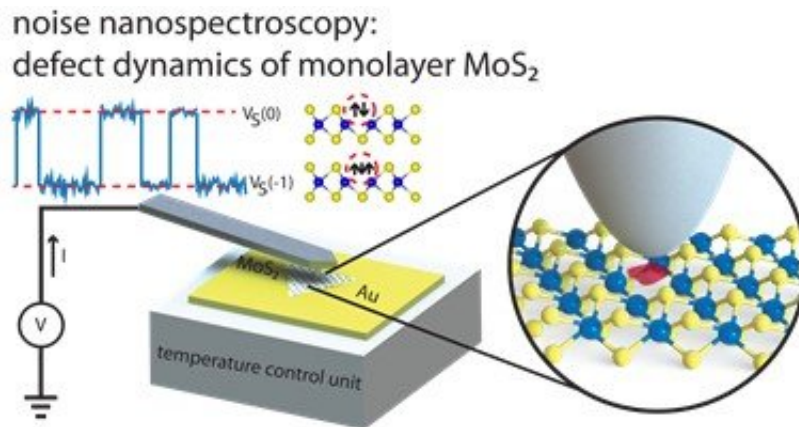


Understanding the impact of defects on the properties of MoS₂

December 22 2017



The study on 2-D molybdenum disulfide (MoS₂) defects employed low frequency noise measurements and conductive atomic force microscopy (C-AFM). The enlarged image shows an AFM cantilever tip pointing to an area with one sulfur monovacancy (area shaded red). As current flows through the AFM tip and the sample, switching events between different ionization states (neutral and charged -1) are measured. With a radius of around 25 nanometers, the AFM tip covers an area that contains around 1-8 sulfur monovacancies. Credit: IBS, published on *Nature Communications*

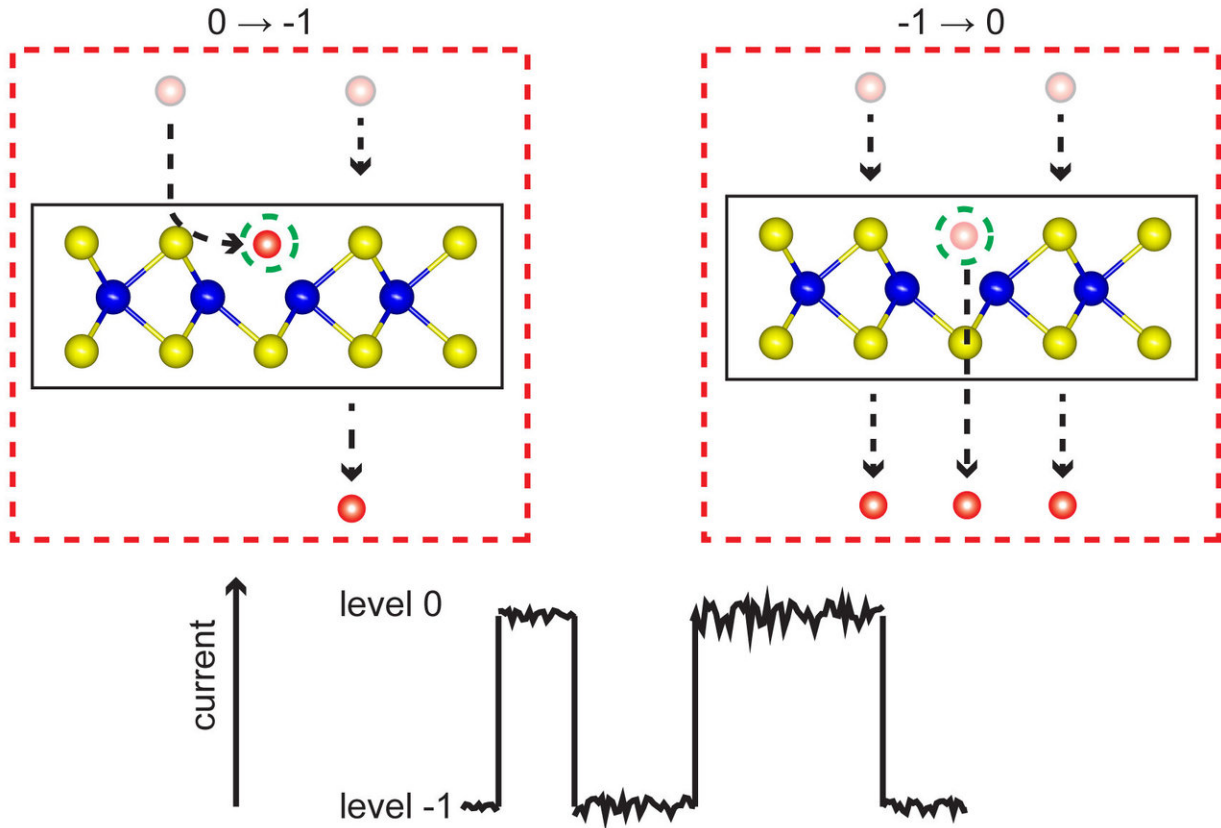
Researchers at the Center for Integrated Nanostructure Physics have shown that defects in monolayer molybdenum disulfide (MoS₂) exhibit electrical switching, providing new insights into the electrical properties of this material. As MoS₂ is one of the most promising 2-D semiconductors, it is expected that these results will contribute to its

future use in opto-electronics.

Defects can cause major changes in the properties of a material, leading to either desirable or unwanted effects. For example, the petrochemical industry has long taken advantage of the catalytic activity of MoS₂ edges, characterized by the presence of a high concentration of defects, to produce petroleum products with reduced sulfur dioxide (SO₂) emissions. On the other hand, having a pristine material is a must in electronics. Currently, silicon rules the industry, because it can be prepared in a virtually defect-free manner. In the case of MoS₂, its suitability for electronic applications is currently limited by the presence of naturally occurring defects. So far, the precise link between these defects and the degraded properties of MoS₂ has been an open question.

In IBS, a team of physicists, material scientists, and electrical engineers worked closely together to explore the electronic properties of sulfur vacancies in MoS₂ monolayers, using a combination of atomic force microscopy (AFM) and noise analysis. The scientists used a metallic AFM tip to measure the noise signal, i.e., the variation of electrical current passing through a single layer of MoS₂ placed on a metal substrate.

The most common defects in MoS₂ are instances of missing single sulfur atoms, also known as sulfur monovacancies. In a perfect sample, each sulfur atom has two valence electrons that bind to two molybdenum electrons. However, where a [sulfur atom](#) is missing, these two molybdenum electrons are left unsaturated, defining the neutral state (0 state) of the defect. However, the team observed rapid switching events in their noise measurements, indicating the state of the vacancy switched between neutral (0 state) and charged (-1 state).



The top graph illustrates the switching processes between the neutral level (0 state) and the charged level (-1 state) that occur when an electron (red circle) from the flowing current is trapped (top left) or released (top right) at the sulfur vacancy defect (marked by green circle). The lower graph shows switching events in the current that occur when electrons from the current passing through the MoS₂ sample are trapped at the vacancy, or released from the vacancy.

Credit: IBS

"The switching between 0 and -1 is happening continuously. While an electron resides at the vacancy for a while, it is missing from the current, such that we observe a current drop," explains Michael Neumann, one of the co-first authors of the study. "This goes a long way towards understanding the known anomalies of MoS₂, and it is very interesting that sulfur vacancies alone are enough to explain these anomalies,

without requiring more complex defects." According to the experiments and earlier calculations, two electrons can be also trapped at the vacancy (-2 state), but this does not seem to be energetically favored.

The new observation that [sulfur](#) vacancies can be charged (-1 and -2 states) sheds light on several MoS₂ anomalies, including its reduced electron mobility observed in MoS₂ monolayer samples: electrons move following the direction of an applied voltage, but get scattered by charged defects. "The -1 state is occupied around 50% of the time, which would lead to scattering of electrons, and thus explain why MoS₂ has such poor mobility," clarifies Neumann. Other MoS₂ characteristics which can be explained by this study are the n-type doping of MoS₂, and the unexpectedly large resistance at the MoS₂-metal junction.

"This research opens up the possibility of developing a new noise nanospectroscopy device capable of mapping one or more defects on a nanoscale scale over a wide area of a 2-D material," concludes the corresponding author Young Hee Lee.

The full study is available on *Nature Communications*.

More information: Seung Hyun Song et al, Probing defect dynamics in monolayer MoS₂ via noise nanospectroscopy, *Nature Communications* (2017). [DOI: 10.1038/s41467-017-02297-3](https://doi.org/10.1038/s41467-017-02297-3)

Provided by Institute for Basic Science

Citation: Understanding the impact of defects on the properties of MoS₂ (2017, December 22) retrieved 18 April 2024 from <https://phys.org/news/2017-12-impact-defects-properties-mos2.html>

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